



General Description

The SJP20NP400 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a wide variety of applications.

Features

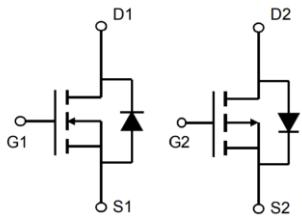
- Low Gate Charge
- High Power and current handing capability
- Lead free product is acquired

Application

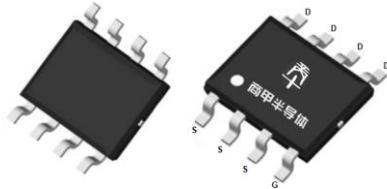
- PWM Applications
- Load Switch
- Power Management

Key Performance Parametes

Parameter	Value	Value	Unit
V_{DS}	20	-20	V
$R_{DS(ON)}_{TYP}$	11.8	26.3	mΩ
I_D	7.9	-5.3	A
Q_G	8.5	8	nC



Schematic Diagram



SOP-8 top&bottom view

Package Marking and Ordering Information

Device/Ordering Code	Marking	Package	Packing	Reel Size	Tape width	Quantity
SJP20NP400	SJP20NP400	SOP-8	Tape	\	\	4000 Pcs

Table 1. Absolute Maximum Ratings ($T_A=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	N Limit	P Limit	Unit
V_{DS}	Drain-Source Voltage ($V_{GS}=0\text{V}$)	20	-20	V
V_{GS}	Gate-Source Voltage ($V_{DS}=0\text{V}$)	± 12	± 12	V
I_D	Drain Current-Continuous($T_A=25^\circ\text{C}$)	7.9	-5.3	A
	Drain Current-Continuous($T_A=100^\circ\text{C}$)	5	-3.3	A
I_{DM} (pulse)	Drain Current-Continuous@ Current-Pulsed (Note 1)	31.6	-21.2	A
P_D	Maximum Power Dissipation($T_A=25^\circ\text{C}$)	1.3	1.3	W
	Maximum Power Dissipation($T_A=100^\circ\text{C}$)	0.5	0.5	W
E_{AS}	Avalanche energy (Note 2)	30	25	mJ
T_J, T_{STG}	Operating Junction and Storage Temperature Range	-55 To 150		°C

Table 2. Thermal Characteristic

Symbol	Parameter	N Limit	P Limit	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to- Ambient	94	94	°C/W



20V NP-Channel Trench Power MOSFET

Table 3. N-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
On/Off States						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ $I_{\text{D}}=250\mu\text{A}$	20			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}}=20\text{V}$, $V_{\text{GS}}=0\text{V}$ $T_J=25^\circ\text{C}$			1	μA
		$V_{\text{DS}}=20\text{V}$, $V_{\text{GS}}=0\text{V}$ $T_J=125^\circ\text{C}$			100	μA
I_{GSS}	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 12\text{V}$, $V_{\text{DS}}=0\text{V}$			± 100	nA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}$, $I_{\text{D}}=250\mu\text{A}$	0.4		1	V
g_{FS}	Forward Transconductance	$V_{\text{DS}}=5\text{V}$, $I_{\text{D}}=3\text{A}$		13		S
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance	$V_{\text{GS}}=4.5\text{V}$, $I_{\text{D}}=3\text{A}$ $T_J=25^\circ\text{C}$		11.8	14.8	$\text{m}\Omega$
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance	$V_{\text{GS}}=2.5\text{V}$, $I_{\text{D}}=2\text{A}$ $T_J=25^\circ\text{C}$		14.8	19.7	$\text{m}\Omega$
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{DS}}=10\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1.0\text{MHz}$		805		pF
C_{oss}	Output Capacitance			88		pF
C_{rss}	Reverse Transfer Capacitance			75		pF
R_g	Gate resistance	$V_{\text{GS}}=0\text{V}$, $V_{\text{DS}}=0\text{V}$, $f=1.0\text{MHz}$		1.4		Ω
Switching Parameters						
$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{GS}}=4.5\text{V}$, $V_{\text{DS}}=10\text{V}$, $R_L=3.3\Omega$, $R_{\text{GEN}}=3\Omega$		6		nS
t_r	Turn-on Rise Time			20		nS
$t_{\text{d(off)}}$	Turn-Off Delay Time			28		nS
t_f	Turn-Off Fall Time			9		nS
Q_g	Total Gate Charge	$V_{\text{GS}}=4.5\text{V}$, $V_{\text{DS}}=10\text{V}$, $I_{\text{D}}=3\text{A}$		8.5		nC
Q_{gs}	Gate-Source Charge			1.4		nC
Q_{gd}	Gate-Drain Charge			1.5		nC
Source-Drain Diode Characteristics						
I_{SD}	Source-Drain Current (Body Diode)				7.9	A
V_{SD}	Forward on Voltage (Note 3)	$V_{\text{GS}}=0\text{V}$, $I_{\text{S}}=3\text{A}$			1.2	V
t_{rr}	Reverse Recovery Time	$I_F=3\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$		4.3		ns
Q_{rr}	Reverse Recovery Charge	$I_F=3\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$		0.6		nC

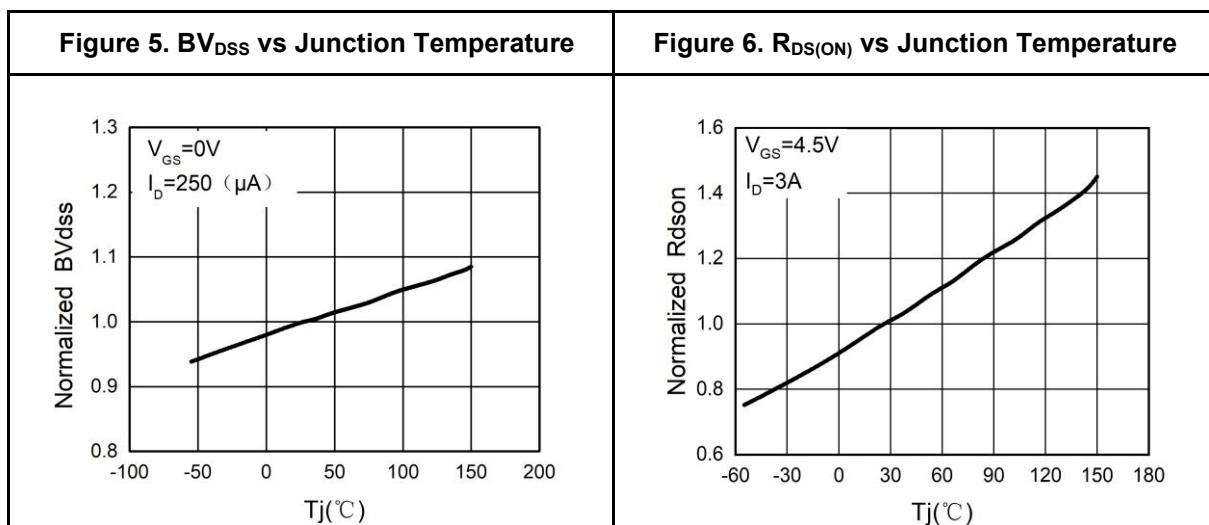
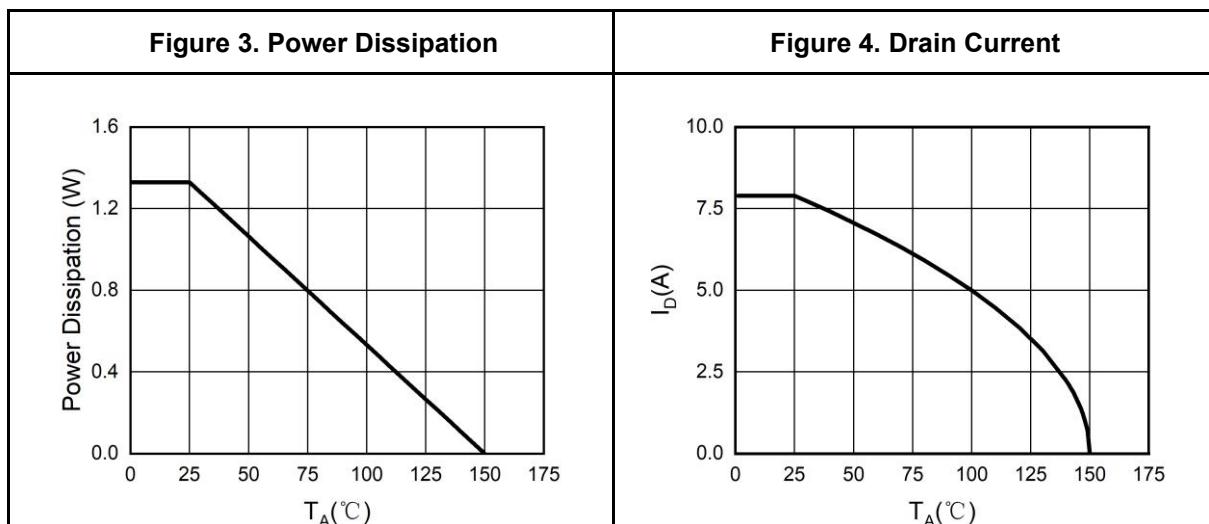
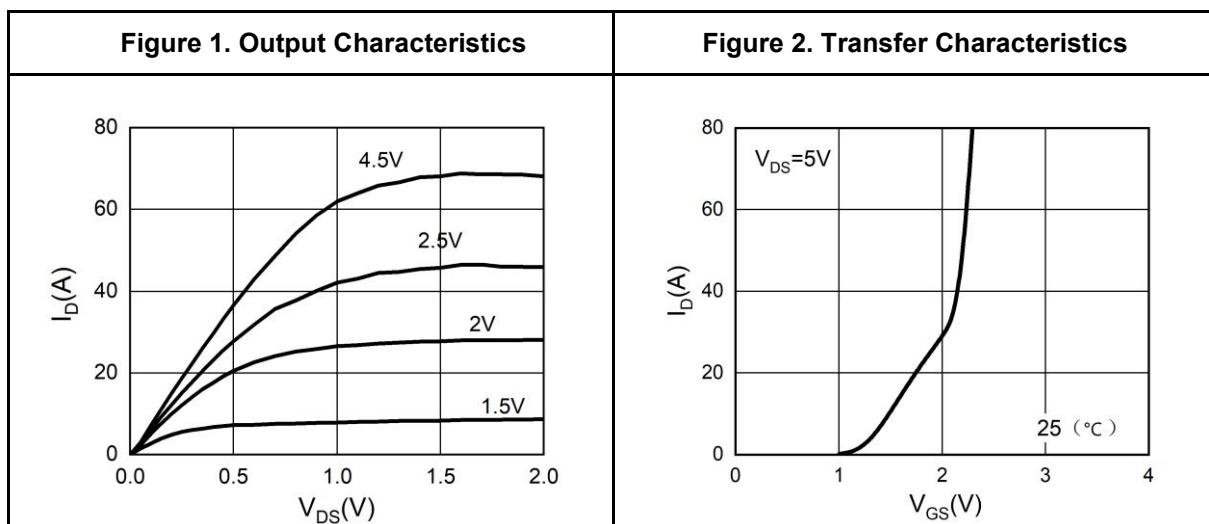
Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature.

Notes 2.E_{AS} condition: $T_J=25^\circ\text{C}$, $V_{\text{DD}}=20\text{V}$, $V_G=10\text{V}$, $R_g=25\Omega$, $L=0.5\text{mH}$.

Notes 3.Repetitive Rating: Pulse width limited by maximum junction temperature.

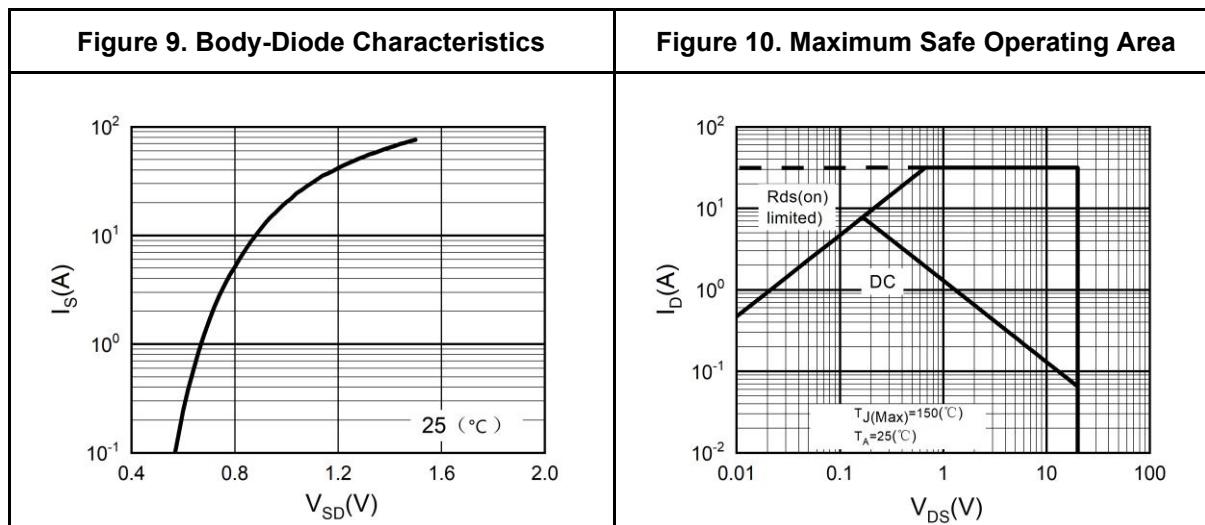
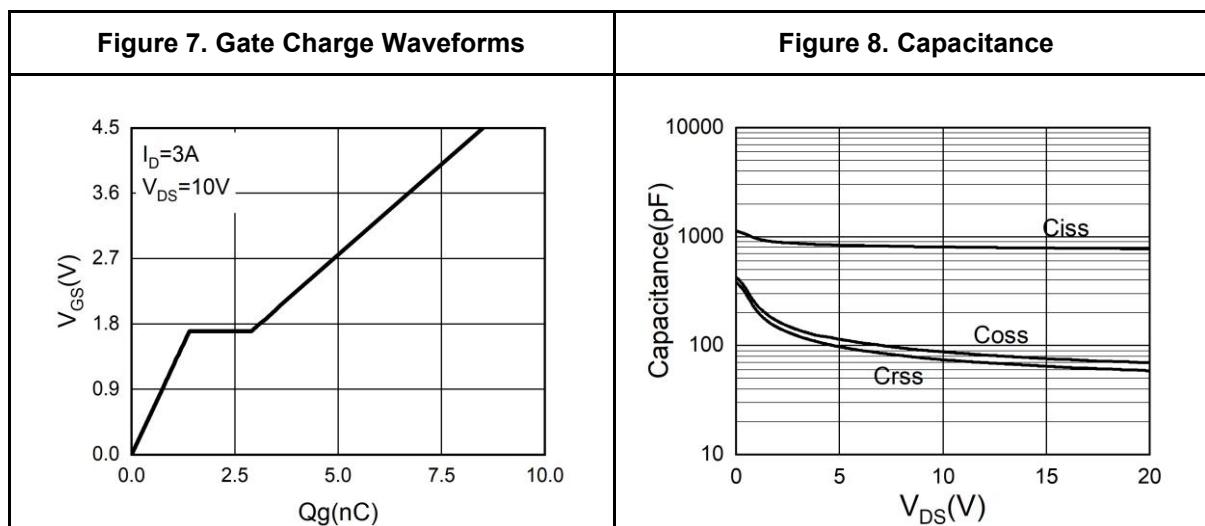


N-Channel Typical Electrical And Thermal Characteristics (Curves)





N-Channel Typical Electrical And Thermal Characteristics (Curves)





20V NP-Channel Trench Power MOSFET

Table 4. P-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
On/Off States						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ $I_{\text{D}}=-250\mu\text{A}$	-20			V
$I_{\text{DS}}^{\text{SS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=-20\text{V}$, $V_{\text{GS}}=0\text{V}$ $T_J=25^\circ\text{C}$			-1	μA
		$V_{\text{DS}}=-20\text{V}$, $V_{\text{GS}}=0\text{V}$ $T_J=125^\circ\text{C}$			-100	μA
I_{GSS}	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 12\text{V}$, $V_{\text{DS}}=0\text{V}$			± 100	nA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}$, $I_{\text{D}}=-250\mu\text{A}$	-0.5		-1	V
g_{FS}	Forward Transconductance	$V_{\text{DS}}=-5\text{V}$, $I_{\text{D}}=-3\text{A}$		11		S
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance	$V_{\text{GS}}=-4.5\text{V}$, $I_{\text{D}}=-3\text{A}$ $T_J=25^\circ\text{C}$		26.3	32.9	$\text{m}\Omega$
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance	$V_{\text{GS}}=-2.5\text{V}$, $I_{\text{D}}=-2\text{A}$ $T_J=25^\circ\text{C}$		35	46.6	$\text{m}\Omega$
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{DS}}=-10\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1.0\text{MHz}$		872		pF
C_{oss}	Output Capacitance			103		pF
C_{rss}	Reverse Transfer Capacitance			87		pF
R_g	Gate resistance	$V_{\text{GS}}=0\text{V}$, $V_{\text{DS}}=0\text{V}$, $f=1.0\text{MHz}$		6		Ω
Switching Parameters						
$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{GS}}=-4.5\text{V}$, $V_{\text{DS}}=-10\text{V}$, $R_L=3.3\Omega$, $R_{\text{GEN}}=3\Omega$		26		nS
t_r	Turn-on Rise Time			45		nS
$t_{\text{d(off)}}$	Turn-Off Delay Time			70		nS
t_f	Turn-Off Fall Time			58		nS
Q_g	Total Gate Charge	$V_{\text{GS}}=-4.5\text{V}$, $V_{\text{DS}}=-1\text{V}$, $I_{\text{D}}=-3\text{A}$		8		nC
Q_{gs}	Gate-Source Charge			1.4		nC
Q_{gd}	Gate-Drain Charge			1.6		nC
Source-Drain Diode Characteristics						
I_{SD}	Source-Drain Current (Body Diode)				-5.3	A
V_{SD}	Forward on Voltage (Note 3)	$V_{\text{GS}}=0\text{V}$, $I_{\text{S}}=-3\text{A}$			-1.2	V
t_{rr}	Reverse Recovery Time	$I_{\text{F}}=-3\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$		17		ns
Q_{rr}	Reverse Recovery Charge	$I_{\text{F}}=-3\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$		7		nC

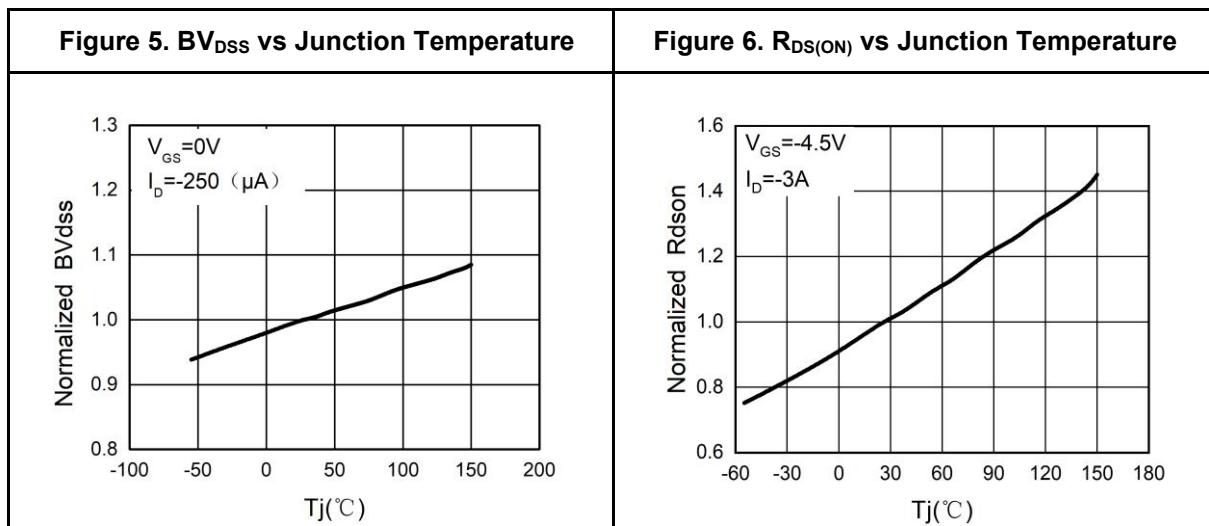
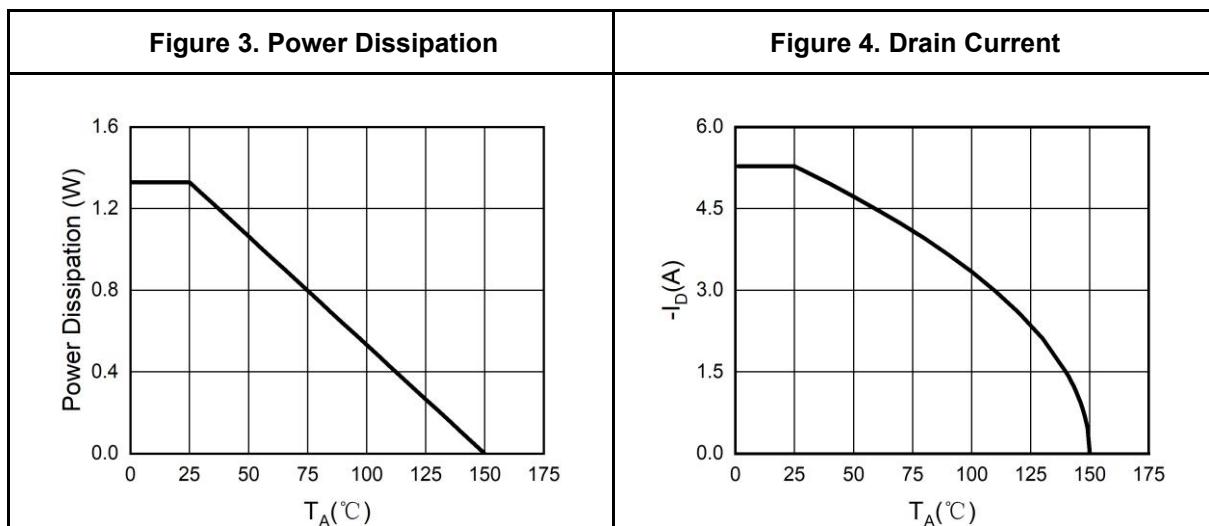
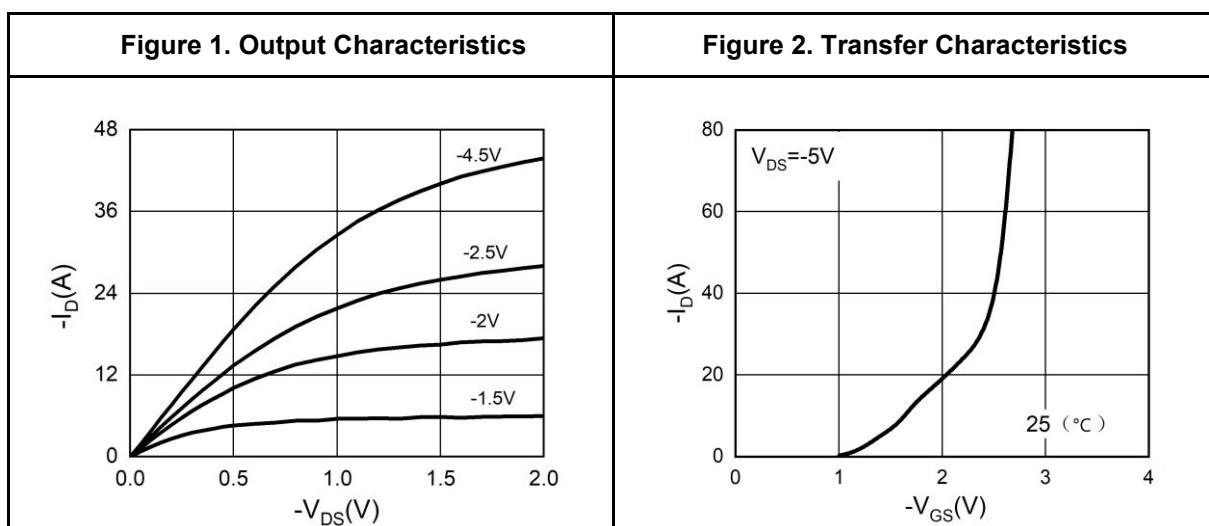
Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature.

Notes 2.E_{AS} condition: $T_J=25^\circ\text{C}$, $V_{\text{DD}}=-20\text{V}$, $V_{\text{G}}=-10\text{V}$, $R_g=25\Omega$, $L=0.5\text{mH}$.

Notes 3.Repetitive Rating: Pulse width limited by maximum junction temperature.

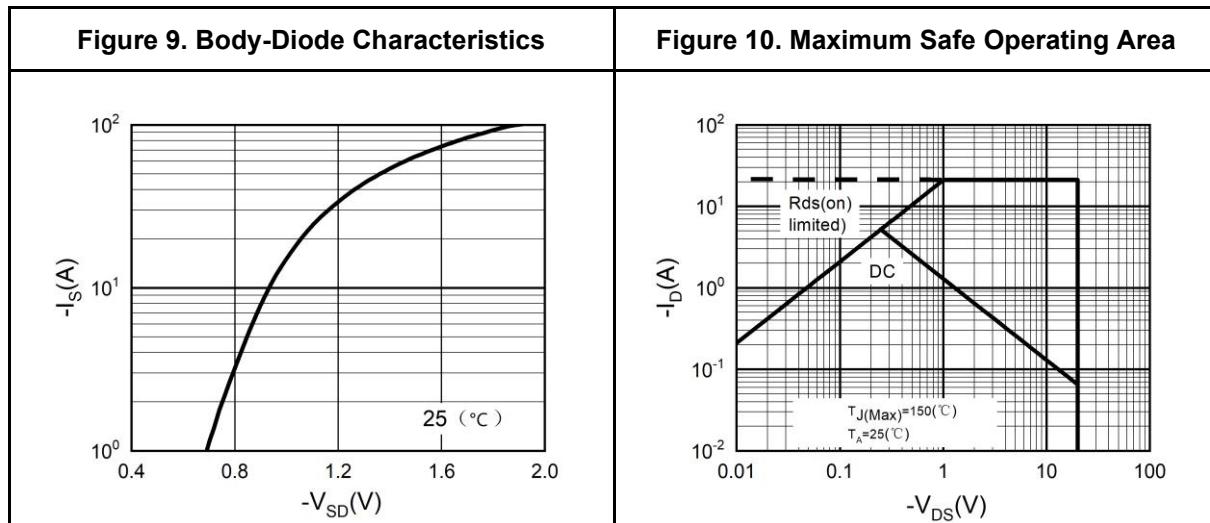
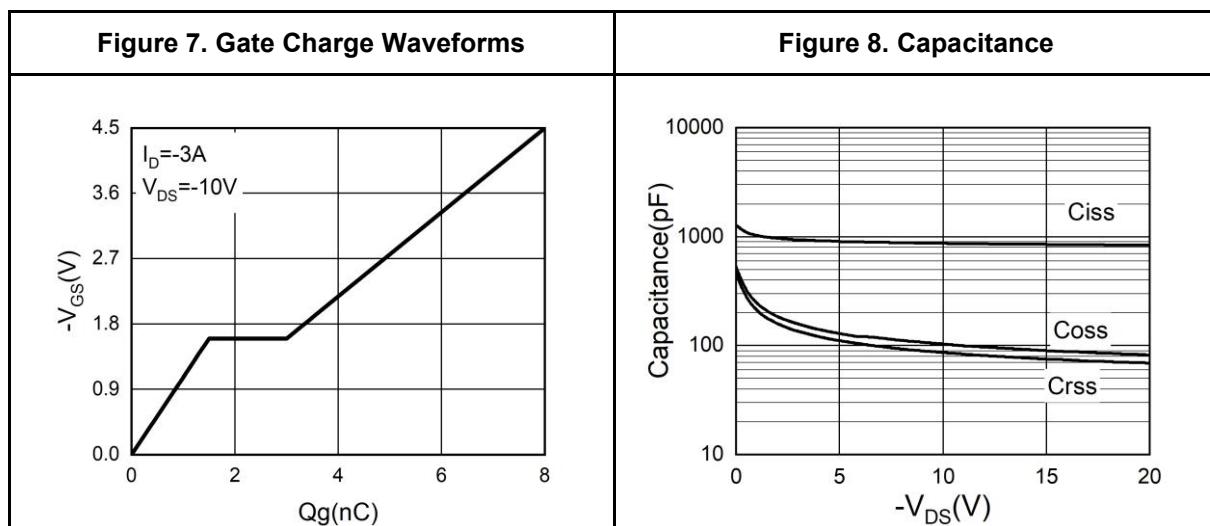


P-Channel Typical Electrical And Thermal Characteristics (Curves)



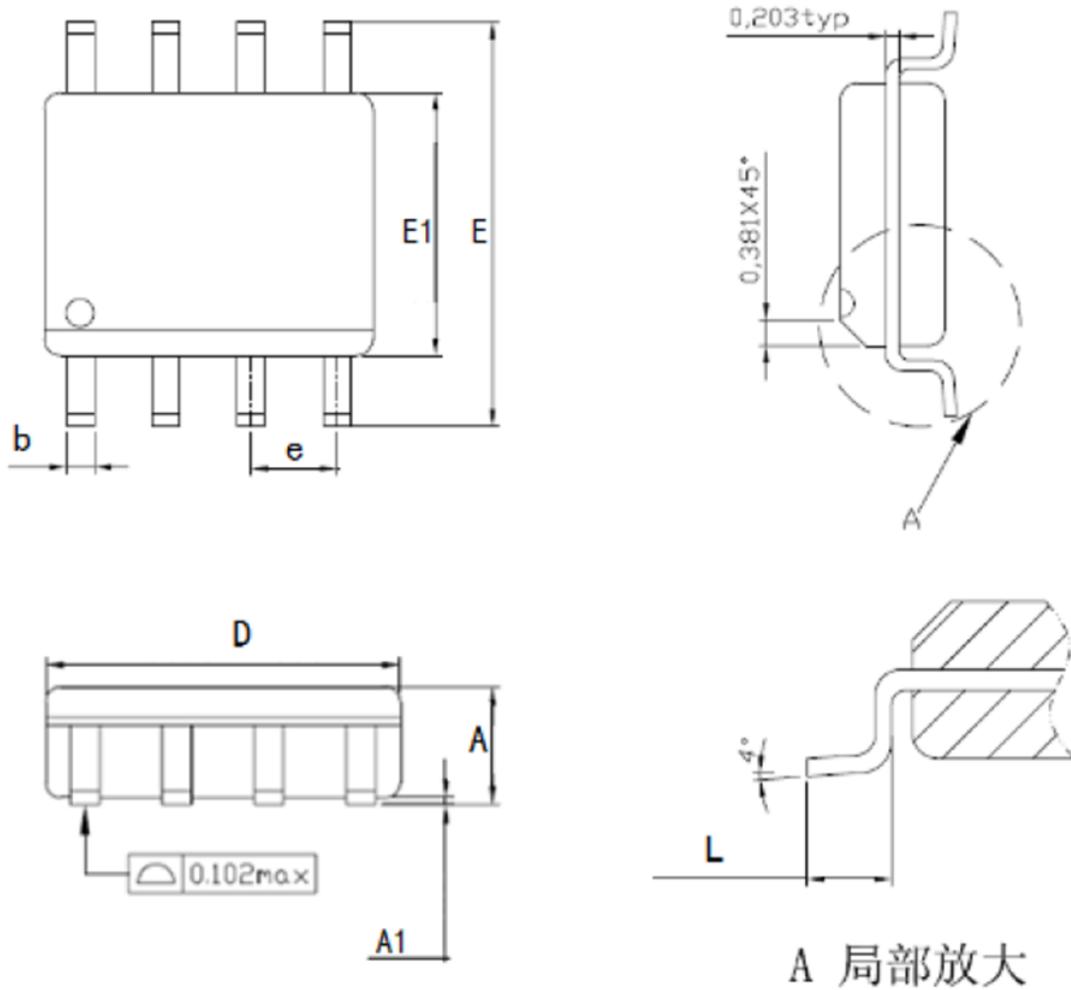


P-Channel Typical Electrical And Thermal Characteristics (Curves)





SOP-8 Package Information



Symbol	Dimensions In Millimeters		
	Min.	Nom.	Max
A	1.35	1.55	1.75
A1	0.1	0.15	0.2
b	0.346	0.406	0.466
D	4.8	4.89	4.98
E	5.75	6.00	6.25
E1	3.81	3.90	3.99
e		1.27TYP	
L	0.406	0.838	1.27



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